Search Notes



Application/Control	No.

Applicant(s)/Patent under Reexamination

10/736,605

HIROSE ET AL.

Examiner
Thien F. Tran

2811

SEARCHED				
Class	Subclass	Date	Examiner	
438	46-47	6/9/2005	π	
438	92-94	6/9/2005	ΤΤ	
438	167, 172	6/9/2005	π	
438	570, 604	6/9/2005	π	
438	606, 718	6/9/2005	π .	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	6/9/2005	π	
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